## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10580610	CID, PAU
Examiner	Art Unit

1626

SEARCHED					
Class	Subclass	Date	Examiner		

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SEARCH NOTES				
Search Notes	Date	Examiner		
restriction requirement	1-26-2008	sl		
STN: registry, caplus, casreact	5-5-2008	sl		
PALM all inventors	5-5-2008	sl		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

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